

CHIP COIL (CHIP INDUCTORS) LQG15HN□□□□02D REFERENCE SPECIFICATION

1. Scope

This reference specification applies to LQG15HN_02 series, for Chip coil (Chip Inductors).

2. Part Numbering

1N0 S 0 2 (ex) LQ 15 Н Ν D G Product ID Structure Dimension Applications Category Inductance Tolerance Features Electrode Packaging $(L \times W)$ and D:Taping Characteristics *B:BULK

*Bulk packing (B) also available

3. Rating

Operating Temperature Range
 Storage Temperature Range
 −55°C to +125°C
 −55°C to +125°C

Customer Part Number	MURATA Part Number	Inductance (nH)	Tolerance	Q (min.)	DC Resistance (Ω max.)	Self Resonant Frequency (MHz min.)	Rated Current (mA)
	LQG15HN1N0B02D				(11)	()	()
	LQG15HN1N0C02D	1.0			0.07		
	LQG15HN1N0S02D	1					
	LQG15HN1N1B02D						
	LQG15HN1N1C02D	1.1					
	LQG15HN1N1S02D						
	LQG15HN1N2B02D						
	LQG15HN1N2C02D	1.2					
	LQG15HN1N2S02D						4000
	LQG15HN1N3B02D						1000
	LQG15HN1N3C02D	1.3					
	LQG15HN1N3S02D				0.00		
	LQG15HN1N5B02D				0.08		
	LQG15HN1N5C02D	1.5					
	LQG15HN1N5S02D	1					
	LQG15HN1N6B02D						
	LQG15HN1N6C02D	1.6					
	LQG15HN1N6S02D	1					
	LQG15HN1N8B02D		B:±0.1nH				
	LQG15HN1N8C02D	1.8	C:±0.2nH	8		6000	
	LQG15HN1N8S02D	1	S:±0.3nH				
	LQG15HN2N0B02D]	
	LQG15HN2N0C02D	2.0					900
	LQG15HN2N0S02D]			0.00		
	LQG15HN2N2B02D				0.09		
	LQG15HN2N2C02D	2.2					
	LQG15HN2N2S02D]					
	LQG15HN2N4B02D]	
	LQG15HN2N4C02D	2.4					
	LQG15HN2N4S02D]			0.40		
	LQG15HN2N7B02D				0.10		
	LQG15HN2N7C02D	2.7					
	LQG15HN2N7S02D]					000
	LQG15HN3N0B02D]	800
	LQG15HN3N0C02D	3.0			0.11		
	LQG15HN3N0S02D						
	LQG15HN3N3B02D]	
	LQG15HN3N3C02D	3.3			0.12		
	LQG15HN3N3S02D]					

Reference Only

Customer Part Number	MURATA Part Number	Inductance (nH)	Tolerance	Q (min.)	DC Resistance (Ω max.)	Self Resonant Frequency (MHz min.)	Rated Curren (mA)
	LQG15HN3N6B02D						
	LQG15HN3N6C02D	3.6					
	LQG15HN3N6S02D				0.13		
	LQG15HN3N9B02D				0.10		
	LQG15HN3N9C02D	3.9					
	LQG15HN3N9S02D						700
	LQG15HN4N3B02D						
	LQG15HN4N3C02D	4.3			0.15	6000	
	LQG15HN4N3S02D		<u> </u>				
	LQG15HN4N7B02D		B:±0.1nH				
	LQG15HN4N7C02D	4.7	C:±0.2nH				
	LQG15HN4N7S02D		S:±0.3nH		0.16		
	LQG15HN5N1B02D				00		
	LQG15HN5N1C02D	5.1					
	LQG15HN5N1S02D						
	LQG15HN5N6B02D						
	LQG15HN5N6C02D	5.6			0.18	5300	
	LQG15HN5N6S02D						600
	LQG15HN6N2B02D						500
	LQG15HN6N2C02D	6.2			0.19	4300	
	LQG15HN6N2S02D						
	LQG15HN6N8G02D						
	LQG15HN6N8H02D	6.8			0.21	4200	
	LQG15HN6N8J02D						
	LQG15HN7N5G02D						
	LQG15HN7N5H02D	7.5			0.24	3900	
	LQG15HN7N5J02D						
	LQG15HN8N2G02D						
	LQG15HN8N2H02D	8.2		8	0.25	3600	
	LQG15HN8N2J02D						500
	LQG15HN9N1G02D						300
	LQG15HN9N1H02D	9.1			0.27	3400	
	LQG15HN9N1J02D						
	LQG15HN10NG02D						
	LQG15HN10NH02D	10			0.29	3200	
	LQG15HN10NJ02D						
	LQG15HN12NG02D						
	LQG15HN12NH02D	12	C++20/		0.40	2800	
	LQG15HN12NJ02D		G:±2% H:±3%				400
	LQG15HN15NG02D		J:±5%				400
	LQG15HN15NH02D	15	J.±3/6		0.45	2300	
	LQG15HN15NJ02D						
	LQG15HN18NG02D						
	LQG15HN18NH02D	18			0.51	2100	
	LQG15HN18NJ02D						350
	LQG15HN22NG02D						330
	LQG15HN22NH02D	22			0.58	1800	
	LQG15HN22NJ02D						
	LQG15HN27NG02D						
	LQG15HN27NH02D	27				1600	
	LQG15HN27NJ02D				0.67		200
	LQG15HN33NG02D				0.67		300
	LQG15HN33NH02D	33				1500	
	LQG15HN33NJ02D						
	LQG15HN39NG02D		1				
	LQG15HN39NH02D	39			1.06	1200	250
	LQG15HN39NJ02D	1	1				



Customer Part Number	MURATA Part Number	Inductance (nH)	Tolerance	Q (min.)	DC Resistance (Ω max.)	Self Resonant Frequency (MHz min.)	Rated Current (mA)
	LQG15HN47NG02D						
	LQG15HN47NH02D	47			1.15	1000	250
	LQG15HN47NJ02D						
	LQG15HN56NG02D						
	LQG15HN56NH02D	56			1.20		
	LQG15HN56NJ02D					800	
	LQG15HN68NG02D					800	
	LQG15HN68NH02D	68	0 00/		1.25		ì
	LQG15HN68NJ02D	1	G:±2%	8			200
	LQG15HN82NG02D		H:±3% J:±5%	0			200
	LQG15HN82NH02D	82	J.±3 /6				
	LQG15HN82NJ02D						
	LQG15HNR10G02D						
	LQG15HNR10H02D	100			1.60	600	
	LQG15HNR10J02D						
	LQG15HNR12G02D						
	LQG15HNR12H02D	120					150
	LQG15HNR12J02D						

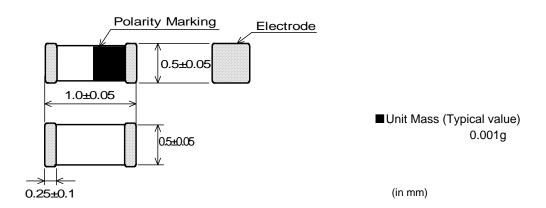
4. Testing Conditions

《Unless otherwise specified》 《In case of doubt》

Temperature : Ordinary Temperature / 15°C to 35°C Temperature : 20°C ± 2°C

Humidity : Ordinary Humidity / 25%(RH) to 85%(RH) Humidity : 60%(RH) to 70%(RH) Atmospheric Pressure : 86kPa to 106kPa

5. Appearance and Dimensions





6. Electrical Performance

No.	Item	Specification	Test Method
6.1	Inductance	Inductance shall meet item 3.	Measuring Equipment:
			Agilent 4291A or equivalent
			Measuring Frequency: 100MHz
			Measuring Condition:
			Test signal level/ about 7dBm Electricallength/ 0.94cm
			Weight/about 1N to 5N
			Measuring Fixture: Agilent 16193A
			Position coil under test as shown in below and
			contact coil with each terminal by adding weight.
			Polarity marking should be a topside, and polarity
			marking should be in the direction of the fixture for position of chip coil.
			To position of only con.
6.2	Q	Q shall meet item 3.	Polarity Marking 11.5mm Measuring Method: See P.10 [Electrical Performance: Measuring Method of Inductance/ Q]
6.3	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment: Digital multi meter
6.4	Self Resonant	S.R.F shall meet item 3.	Measuring Equipment:
	Frequency (S.R.F)		Agilent 8753C or equivalent
6.5	Rated Current	Self temperature rise shall be	The rated current is applied.
		limited to 25°C max.	

7. Mechanical Performance

No.	Item	Specification	Test Method
7.1	Shear Test	Chip coil shall not be damaged after tested as test method.	Substrate: Glass-epoxy substrate Land 0.5 O.5 (in mm) O.55 Force: 5N Hold Duration: 5s±1s Applied Direction: Parallel to PCB Chip Coil Substrate



No.	Item	Specification	Test Method
7.2	Bending Test	Chip coil shall not be damaged after tested as test method.	Substrate: Glass-epoxy substrate (100mm×40mm×0.8mm) Speed of Applying Force: 1mm / s Deflection: 2mm Hold Duration: 30s
			Pressure jig R340 F Deflection 45 45 Product (in mm)
7.3	Vibration	Appearance: No damage Inductance Change: within ±10%	Oscillation Frequency: 10Hz to 55Hz to 10Hz for 1 min Total Amplitude: 1.5mm Testing Time: A period of 2 hours in each of 3 mutually perpendicular directions.
7.4	Solderability	The wetting area of the electrode shall be at least 90% covered with new solder coating.	Flux: Ethanol solution of rosin 25(wt)% (Immersed for 5s to 10s) Solder: Sn-3.0Ag-0.5Cu Pre-Heating: 150°C±10°C / 60s to 90s Solder Temperature: 240°C±5°C Immersion Time: 3s±1s
7.5	Resistance to Soldering Heat	Appearance: No damage Inductance Change: within ±10%	Flux: Ethanol solution of rosin 25(wt)% (Immersed for 5s to 10s) Solder: Sn-3.0Ag-0.5Cu Pre-Heating: 150°C±10°C / 1 min to 2 min Solder Temperature: 270°C±5°C Immersion Time: 10s±1s Then measured after exposure in the room condition for 24h±2h.

8. Environmental Performance

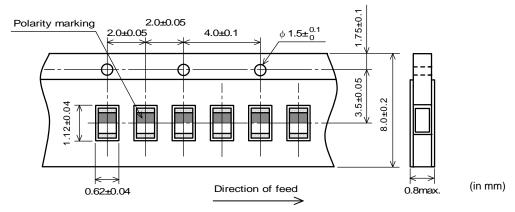
It shall be soldered on the substrate.

No.	Item	Specification	Test Method
8.1	Humidity	Appearance: No damage Inductance Change: within ±10%	Temperature: 40°C±2°C Humidity: 90%(RH) to 95%(RH) Time: 1000h (+48h,-0h) Then measured after exposure in the room
8.2	Heat Life		condition for 24h±2h. Temperature: 125°C±2°C Current: Rated Current (See the 3.) Time: 1000h (+48h,-0h)
8.3	Humidity Load		Then measured after exposure in the room condition for 24h±2h. Temperature: 40°C±2°C
0.0	Trainiony 2000		Humidity: 90%(RH) to 95%(RH) Current: Rated Current (See the 3.) Time: 1000h (+48h,-0h) Then measured after exposure in the room condition for 24h±2h.
8.4	Temperature Cycle		1 cycle: 1 step: -55°C (+0°C,-3°C) / 30 min±3 min 2 step: Ordinary temp. / 2 min to 3 min 3 step: +125°C (+3°C,-0°C) / 30 min±3 min 4 step: Ordinary temp. / 2 min to 3 min Total of 10 cycles Then measured after exposure in the room condition for 24h±2h.



9. Specification of Packaging

9.1 Appearance and Dimensions of paper tape (8mm-wide)



9.2 Specification of Taping

(1) Packing quantity (standard quantity)

10,000 pcs. / reel

(2) Packing Method

Products shall be packed in the cavity of the base tape and sealed by top tape and bottom tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Base tape and Top tape has no spliced point.

(5) Missing components number

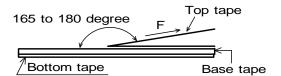
Missing components number within 0.1 % of the number per reel or 1 pc., whichever is greater, and are not continuous. The Specified quantity per reel is kept.

9.3 Pull Strength

Top tape	5N min
Bottom tape	ON HIIII.

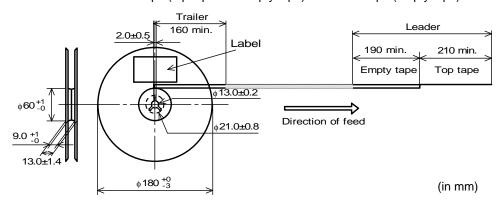
9.4 Peeling off force of cover tape

Speed of Peeling off	300mm / min
Peeling off force	0.1N to 0.6N
	(minimum value is typical)



9.5 Dimensions of Leader-tape, Trailer and Reel

There shall be leader-tape (top tape and empty tape) and trailer-tape (empty tape) as follows.



9.6 Marking for reel

Customer part number, MURATA part number, Inspection number (*1), RoHS marking (*2), Quantity etc \cdots

*1) <Expression of Inspection No.>

(1) Factory Code

(2) Date First digit : Year / Last digit of year

Second digit: Month / Jan. to Sep. \rightarrow 1 to 9, Oct. to Dec. \rightarrow O, N, D

Third, Fourth digit: Day

(3) Serial No.

*2) <Expression of RoHS marking>

ROHS
$$-\underline{Y}(\underline{\Delta})$$

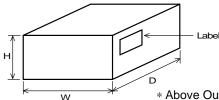
(1) (2)

- (1) RoHS regulation conformity parts.
- (2) MURATA classification number

9.7 Marking for Outside package (corrugated paper box)

Customer name, Purchasing order number, Customer part number, MURATA part number, RoHS marking (*2), Quantity, etc ···

9.8. Specification of Outer Case



Outer Case Dimensions (mm)			Standard Reel Quantity in Outer Case (Reel)
W	D	Н	III Outer Case (Reei)
186	186	93	5

* Above Outer Case size is typical. It depends on a quantity of an order.

10. 🛕 Caution

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

- (1) Aircraft equipment
- (2) Aerospace equipment
- (3) Undersea equipment
- (4) Power plant control equipment
- (5) Medical equipment
- (6) Transportation equipment (vehicles, trains, ships, etc.)
- (7) Traffic signal equipment
- (8) Disaster prevention / crime prevention equipment
- (9) Data-processing equipment
- (10) Applications of similar complexity and /or reliability requirements to the applications listed in the above

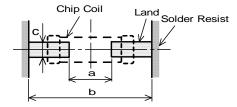
11. Notice

Products can only be soldered with reflow.

This product is designed for solder mounting.

Please consult us in advance for applying other mounting method such as conductive adhesive.

11.1 Land pattern designing



а	0.4
b	1.4 to 1.5
С	0.5 to 0.6

(in mm)



11.2 Flux, Solder

·Use rosin-based flux.

Don't use highly acidic flux with halide content exceeding 0.2(wt)% (chlorine conversion value).

Don't use water-soluble flux.

- ·Use Sn-3.0Ag-0.5Cu solder.
- •Standard thickness of solder paste : $100 \,\mu$ m to $150 \,\mu$ m.

11.3 Reflow soldering conditions

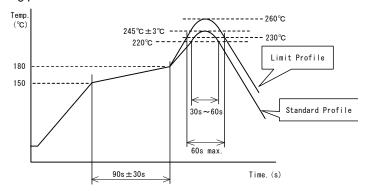
- •Inductance value may be changed a little due to the amount of solder.
- So, the chip coil shall be soldered by reflow so that the solder volume can be controlled.
- •Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 150°C max. Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max.

Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of products quality.

•Standard soldering profile and the limit soldering profile is as follows.

The excessive limit soldering conditions may cause leaching of the electrode and/or resulting in the deterioration of product quality.

·Reflow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150°C∼180°	°C, 90s±30s
Heating	above 220°C, 30s∼60s	above 230°C, 60s max.
Peak temperature	245°C±3°C	260°C, 10s
Cycle of reflow	2 times	2 times

11.4 Reworking with soldering iron

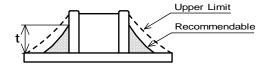
The following conditions must be strictly followed when using a soldering iron.

Pre-heating	150°C,1 min
Tip temperature	350°C max.
Soldering iron output	80W max.
Tip diameter	ϕ 3mm max.
Soldering time	3(+1, -0)s
Time	2 times

Note: Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the products due to the thermal shock.

11.5 Solder Volume

- Solder shall be used not to be exceededthe upper limits as shown below.
- Accordingly increasing the solder volume, the mechanical stress to Chip is also increased.
 Exceeding solder volume may cause the failure of mechanical or electrical performance.



1/3T≦t≦T

T: thickness of product

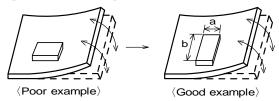


11.6 Product's location

The following shall be considered when designing and laying out P.C.B.'s.

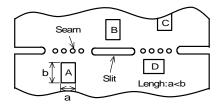
 P.C.B. shall be designed so that products are not subject to the mechanical stress due to warping the board.

[Products direction]



Products shall be located in the sideways direction (Length: a < b) to the mechanical stress.

(2) Products location on P.C.B. separation



Products (A, B, C, D) shall be located carefully so that products are not subject to the mechanical stress due to warping the board.

Because they may be subjected the mechanical stress in order of $A > C > B \equiv D$.

11.7 Cleaning Conditions

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max. (40°C max for IPA.)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.

Power: 20 W / I max. Frequency: 28kHz to 40kHz Time: 5 min max.

- (3) Cleaner
 - 1. Alcohol type cleaner Isopropyl alcohol (IPA)
 - 2. Aqueous agent PINE ALPHA ST-100S
- (4) There shall be no residual flux and residual cleaner after cleaning. In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning Please contact us.

11.8 Resin coating

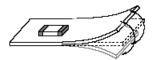
The inductance value may change and/or it may affect on the product's performance due to high cure-stress of resin to be used for coating/molding products. So please pay your careful attention when you select resin. In prior to use, please make the reliability evaluation with the product mounted in your application set.

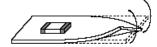
11.9 Handling of a substrate

After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

Excessive mechanical stress may cause cracking in the product.

Bending Twisting







11.10 Storage and Handing Requirements

(1) Storage period

Use the products within 6 months after delivered.

Solderability should be checked if this period is exceeded.

(2) Storage conditions

•Products should be stored in the warehouse on the following conditions.

Temperature : -10°C to 40°C

Humidity : 15% to 85% relative humidity No rapid change on temperature and humidity

Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.

- Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.
- Products should be s stored in the warehouse without heat shock, vibration, direct sunlight and so on.
- Products should be stored under the airtight packaged condition.

(3) Handling Condition

Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

12./\!\ Note

- (1) Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2) You are requested not to use our product deviating from the reference specifications.
- (3) The contents of this reference specification are subject to change without advance notice.

Please approve our product specifications or transact the approval sheet for product specifications before ordering.

< Electrical Performance: Measuring Method of Inductance / Q>-

(1) Residual elements and stray elements of test fixture can be described by F-parameter shown in following.

$$Z_{\text{m}} \Rightarrow \begin{array}{c} I_{2} \\ \downarrow \\ V_{1} \end{array}$$

$$C \qquad D \qquad V_{2} \qquad Z_{N}$$

$$T_{\text{est Head}} \qquad T_{\text{est fixture}} \qquad P_{\text{roduct}}$$

$$\left[\begin{array}{c} V_1 \\ I_1 \end{array}\right] = \left[\begin{array}{cc} A & B \\ C & D \end{array}\right] \left[\begin{array}{c} V_2 \\ I_2 \end{array}\right]$$

(2) The impedance of chip coil Zx and measured value Zm can be described by input/output current/voltage.

$$Zm = \frac{V_1}{I_1}$$
 $Zx = \frac{V_2}{I_2}$

(3) Thus, the relation between Zx and Zm is following:

$$Z = \alpha \frac{Zm - \beta}{1 - Zm \Gamma}$$
 where, $\alpha = D / A = 1$
 $\beta = B / D = Zsm - (1 - Yom Zsm)Zss$
 $\Gamma = C / A = Yom$

Zsm: measured impedance of short chip
Zss: residual impedance of short chip (0.556nH)
Yom: measured admittance when opening the fixture

(4) Lx and Qx shall be calculated with the following equation.